# Advance Information

# **TRIACS**

# **Silicon Bidirectional Thyristors**

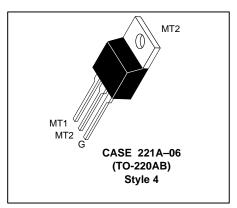
Designed for high performance full-wave ac control applications where high noise immunity and commutating di/dt are required.

- Blocking Voltage to 800 Volts
- On-State Current Rating of 12 Amperes RMS at 70°C
- · Uniform Gate Trigger currents in Three Modes
- High Immunity to dv/dt 250 V/µs minimum at 125°C
- High Commutating di/dt 6.5 A/ms minimum at 125°C
- Industry Standard TO-220 AB Package
- High Surge Current Capability 120 Amperes

# MAC12

\*Motorola preferred devices

**TRIACS** 12 AMPERES RMS 400 thru 800 **VOLTS** 



### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter		Symbol	Value	Unit	
Peak Repetitive Off-State Voltage (1) (T <sub>J</sub> = -40 to 125°C, Sine Wave, 50 to 60 Hz, Gate Open)	MAC12D MAC12M MAC12N	V <sub>DRM</sub>	400 600 800	Volts	
On-State RMS Current (Full Cycle Sine Wave, 60 Hz, T <sub>C</sub> = 70°C)		I <sub>T(RMS)</sub>	12	А	
Peak Non-repetitive Surge Current (One Full Cycle, 60 Hz, T <sub>J</sub> = 125°C)		<sup>I</sup> TSM	100	А	
Circuit Fusing Consideration (t = 8.3 ms)		l <sup>2</sup> t	41	A <sup>2</sup> sec	
Peak Gate Power (Pulse Width ≤ 1.0 μs, T <sub>C</sub> = 80°C)		P <sub>GM</sub>	16	Watts	
Average Gate Power (t = 8.3 ms, T <sub>C</sub> = 80°C)		P <sub>G(AV)</sub>	0.35	Watts	
Operating Junction Temperature Range		TJ	-40 to +125	°C	
Storage Temperature Range		T <sub>stg</sub>	-40 to +150	°C	

Thermal Resistance — Junction to Case — Junction to Ambient	R <sub>θ</sub> JC R <sub>θ</sub> JA	2.2 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 10 Seconds	TL	260	°C

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Peak Repetitive Blocking Current (VD = Rated VDRM, Gate Open)	T <sub>J</sub> = 25°C T <sub>J</sub> =1 25°C	I <sub>DRM</sub>	_	_ _	0.01 2.0	mA

<sup>(1)</sup> VDRM and VRRM for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

This document contains information on a new product. Specifications and information herein are subject to change without notice.

Preferred devices are Motorola recommended choices for future use and best overall value.

## REV<sub>1</sub>

## **MAC12 SERIES**

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
ON CHARACTERISTICS	•		•		
Peak On-State Voltage* (I <sub>TM</sub> = ±17 A)	V <sub>TM</sub>	_	_	1.85	Volts
Continuous Gate Trigger Current ( $V_D$ = 12 V, $R_L$ = 100 $\Omega$ ) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	IGT	5.0 5.0 5.0	13 16 18	35 35 35	mA
Hold Current (V <sub>D</sub> = 12 V, Gate Open, Initiating Current = ±150 mA)	lн	_	20	40	mA
Latch Current ( $V_D = 24 \text{ V}, I_G = 35 \text{ mA}$ ) MT2(+), G(+); MT2(-), G(-) MT2(+), G(-)	IL	_ _	20 30	50 80	mA
Gate Trigger Voltage ( $V_D$ = 12 V, $R_L$ = 100 $\Omega$ ) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-)	VGT	0.5 0.5 0.5	0.69 0.77 0.72	1.5 1.5 1.5	Volts
DYNAMIC CHARACTERISTICS	•				
Rate of Change of Commutating Current* ( $V_D = 400 \text{ V}$ , ITM =4.4A, Commutating dv/dt = 18 V/ $\mu$ s, Gate Open, $T_J = 125^{\circ}$ C, f = 250 Hz, No Snubber)	(dv/dt)c	6.5	_	_	A/ms
Critical Rate of Rise of Off–State Voltage (V <sub>D</sub> = Rated V <sub>DRM</sub> , Exponential Waveform, Gate Open, T <sub>J</sub> = 125°C)	dv/dt	250	_	_	V/μs

<sup>\*</sup>Indicates Pulse Test: Pulse Width ≤ 2.0 ms, Duty Cycle ≤ 2%.